

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. <b>14219-0079US1</b>	Application No. <b>10/526,278</b>
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary)  (37 CFR §1.98(b))		Applicant <b>Christian Block et al.</b>	
		Filing Date <b>March 1, 2005</b>	Group Art Unit <b>2836</b>

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	2	3,728,731	04-1973	Choi et al.			
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